

# Z540.1

# FLUKE®

## Certificate of Calibration Everett Service Center



ISO 9001:2008 (10100/2)

**Certificate Number:** 649084-708601073:1387570619

<b>Result Summary:</b> PASS	<b>Date of Calibration:</b> 20 December 2013
<b>Data Type:</b> FOUND-LEFT	<b>Recommended Due Date:</b> 20 December 2014
<b>Manufacturer:</b> FLUKE	<b>Date of Certificate:</b> 20 December 2013
<b>Model:</b> 70 III	<b>Received Date:</b> 20 December 2013
<b>Serial Number:</b> 708601073	<b>Temperature:</b> 22.0 °C
<b>Description:</b> MULTIMETER	<b>Relative Humidity:</b> 33 %RH
<b>Procedure Name:</b> Fluke 70-3: (1 year) CAL VER/Alt 5520A	<b>Procedure Revision:</b> 1.0

**Customer Name:** STATE OF WASHINGTON  
**City, State:** SEATTLE, WA  
**Customer Item ID:**  
**PO Number:** WSP CCS  
**RMA Number:** 30435763

This calibration is traceable to the International System of Units (SI), through National Metrology Institutes, radiometric techniques, or natural physical constants. This certificate applies only to the item identified and shall not be reproduced other than in full, without the specific written approval by Fluke Corporation. Calibration certificates without signature are not valid. The calibration has been completed in accordance with Fluke Electronics Corporation Quality System Document 111.0 Rev 116 08/12 and Fluke Customer Support Services QAM 400 Rev. 002 03/22/2012.

The Data Type found in this certificate must be interpreted as:

- As - Found Calibration data collected before the unit is adjusted and / or repaired.
- As - Left Calibration data collected after the unit has been adjusted and / or repaired.
- Found-Left Calibration data collected without any adjustment and / or repair performed.

This calibration conforms to the requirements of ANSI/NCSL Z540-1-1994 (R2002).

In the attached measurement results, deviation may be expressed with units, Measured Value (MV) - Nominal Value (NV) or as a proportion of the nominal value ((MV-NV)/NV), expressed without units with a scalar multiplier such as % (0.01), or as a ratio of the units (mV/V,  $\mu$ V/V, etc.) Descriptions such as  $\mu$ V/V, and others, where used to annotate results or column headings are the preferred replacements for what was historically labeled as "ppm" or parts-per-million and described the results in that column, unless otherwise noted by units symbols.

Where applicable, the expanded uncertainty of measurement at the time of test is given in the following pages. They are calculated in accordance with the method described in the ISO Guide to the Expression of Uncertainty in Measurement (GUM). The reported expanded uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k, such that the confidence level approximates 95%.

Where applicable, the Test Uncertainty Ratio (TUR) is provided in the following pages. Unless otherwise stated, the TUR for a given measurement result is 4:1 or greater.

Results are reviewed to establish where any measurement results exceeded the manufacturer's specifications.

Measured values (MV) greater than the Manufacturer's specification (Spec) are indicated by "I".

Corey Dinardi  
Metrology Technician

Randy Lemon  
Lead Metrologist



Certificate Number:  
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Calibration Date:  
20-Dec-13

### Standards Used

Asset #	Instrument Model	Cal Date	Cal Due
13600	FLUKE 5520A/1GHZ CALIBRATOR	02 September 2013	02 March 2014

### Calibration Results

Function/Range	Nominal Value	Measured Value	TUR	Manufacturer's Specifications	
				Lower Limit	Upper Limit
<b>DISPLAY TEST</b>					
Result of Operator Evaluation		PASS			
<b>RESISTANCE TEST</b>					
<b>320Ohm Range</b>					
0.0 Ohm	0.00	0.0		0.0	0.2
100.0 Ohm	100.00	99.9		99.3	100.7
<b>3200Ohm Range</b>					
1000 Ohm	1000.0	1000		994	1006
<b>32kOhm Range</b>					
10.00 kOhm	10.000	10.00		9.94	10.06
<b>320kOhm Range</b>					
100.0 kOhm	100.00	100.0		99.4	100.6
<b>3.2MOhm Range</b>					
1.000 MOhm	1.0000	1.000		0.994	1.006
<b>32MOhm Range</b>					
10.00 MOhm	10.000	10.00		9.79	10.21
<b>DIODE TEST</b>					
Beeper Audible		PASS			
Beeper OFF		PASS			
<b>DC VOLTAGE TEST</b>					
<b>320mV Range</b>					
300.0 mV	300.00	299.7		299.0	301.0
<b>DC VOLTAGE TEST</b>					
<b>3.2V Range</b>					
2.700 V	2.7000	2.699		2.691	2.709
<b>32V Range</b>					
27.00 V	27.000	26.99		26.91	27.09
<b>320V Range</b>					
270.0 V	270.00	270.0		269.1	270.9
<b>600V Range</b>					
600 V	600.0	600		597	603
<b>AC VOLTAGE TEST</b>					
<b>3.2V Range</b>					
2.700 V @ 100 Hz	2.7000	2.701		2.644	2.756
2.700 V @ 500 Hz	2.7000	2.688		2.644	2.756
<b>600V Range</b>					
600 V @ 100 Hz	600.0	600		586	614
600 V @ 1 kHz	600.0	600		586	614

End of Report